



Schedule of Scope to Certificate of Conformity Approved Process

IECQ Certificate No.: IECQ-P JQAJP 13.0009

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In respect of standards and specifications:

IEC 60747-1:2006

Semiconductor devices
- Part 1: General

IEC 60748-1:2002

Semiconductor devices - Integrated circuits
- Part 1: General

IEC 60748-20:1988

Semiconductor devices. Integrated circuits
- Part 20: Generic specification for film integrated circuits and
hybrid film integrated circuits

ISO 9001:2015

Quality management systems - Requirements

Component:

Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

Scope:

The design, manufacture and test of Semiconductor devices, Integrated circuits, Hybrid integrated circuits.

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